

<b>Notice of References Cited</b>	Application/Control No. 10/542,406	Applicant(s)/Patent Under Reexamination VERNEAU, BERNADETTE	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0035944	02-2006	Muto et al.	514/365
	B	US-			
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	D	US-			
	E	US-			
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